

# TC74VCX16843FT

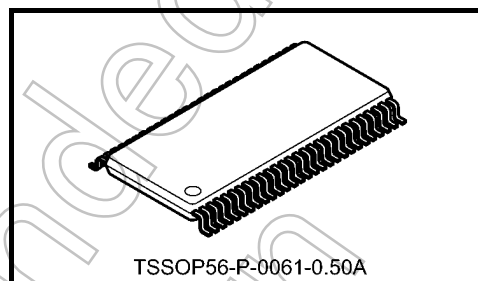
## Low-Voltage 18-Bit D-Type Latch with 3.6-V Tolerant Inputs and Outputs

The TC74VCX16843FT is a high-performance CMOS 18-bit D-type latch. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to 3.6 V.

The TC74VCX16843FT can be used as two 9-bit latches or one 18-bit latch. The 18 latches are transparent D-type latches. The device has noninverting data (D) inputs and provides true data at its outputs. While the latch-enable (1LE or 2LE) input is high, the Q outputs of the corresponding 9-bit latch follow the D inputs. When LE is taken low, the Q outputs are latched at the levels set up at the D inputs. CLR and PR are independent of the LE and are accomplished by setting the appropriate input low. When the OE input is high, the outputs are in a high-impedance state. This device is designed to be used with 3-state memory address drivers, etc.

All inputs are equipped with protection circuits against static discharge.

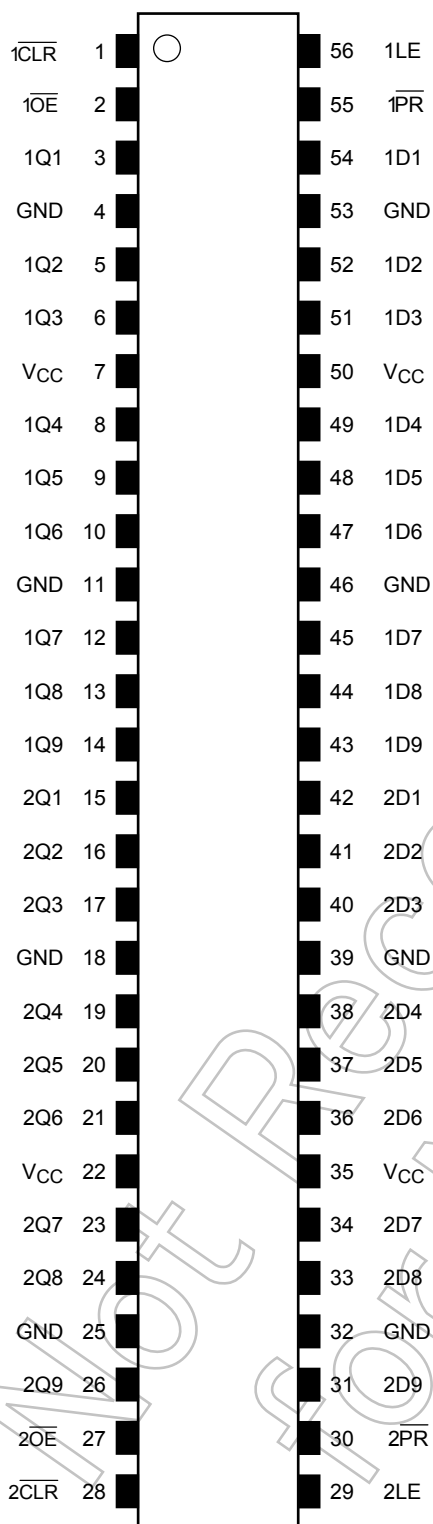


Weight: 0.25 g (typ.)

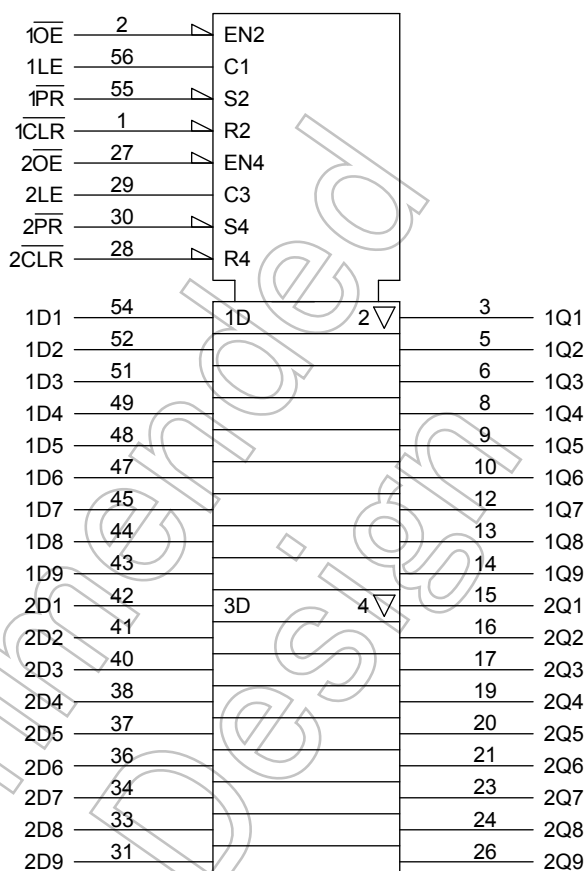
### Features

- Low-voltage operation:  $V_{CC} = 1.8$  to  $3.6$  V
- High-speed operation
  - :  $t_{pd} = 3.0$  ns (max) ( $V_{CC} = 3.0$  to  $3.6$  V)
  - :  $t_{pd} = 3.7$  ns (max) ( $V_{CC} = 2.3$  to  $2.7$  V)
  - :  $t_{pd} = 7.4$  ns (max) ( $V_{CC} = 1.8$  V)
- Output current:  $I_{OH}/I_{OL} = \pm 24$  mA (min) ( $V_{CC} = 3.0$  V)
  - :  $I_{OH}/I_{OL} = \pm 18$  mA (min) ( $V_{CC} = 2.3$  V)
  - :  $I_{OH}/I_{OL} = \pm 6$  mA (min) ( $V_{CC} = 1.8$  V)
- Latch-up performance:  $-300$  mA
- ESD performance: Machine model  $\geq \pm 200$  V
  - Human body model  $\geq \pm 2000$  V
- Package: TSSOP
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs

## Pin Assignment (top view)



## IEC Logic Symbol



**Truth Table (each 9-bit latch)**

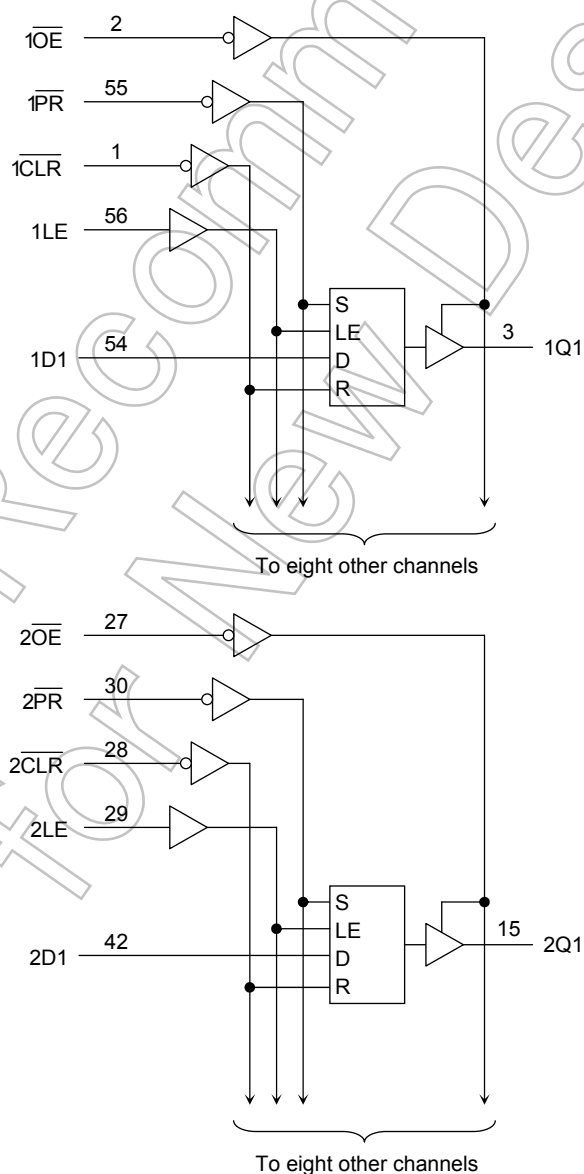
Inputs					Output Q
$\overline{\text{PR}}$	$\overline{\text{CLR}}$	$\overline{\text{OE}}$	LE	D	
L	X	L	X	X	H
H	L	L	X	X	L
H	H	L	H	L	L
H	H	L	H	H	H
H	H	L	L	X	Qn
X	X	H	X	X	Z

X: Don't care

Z: High impedance

Qn: Q outputs are latched at the time when the LE input is taken to a low logic level.

**System Diagram**



**Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	-0.5 to 4.6	V
DC input voltage	$V_{IN}$	-0.5 to 4.6	V
DC output voltage	$V_{OUT}$	-0.5 to 4.6 (Note 2)	V
		-0.5 to $V_{CC} + 0.5$ (Note 3)	
Input diode current	$I_{IK}$	-50	mA
Output diode current	$I_{OK}$	$\pm 50$ (Note 4)	mA
DC output current	$I_{OUT}$	$\pm 50$	mA
Power dissipation	$P_D$	400	mW
DC $V_{CC}$ /ground current per supply pin	$I_{CC}/I_{GND}$	$\pm 100$	mA
Storage temperature	$T_{stg}$	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 2: OFF state

Note 3: High or low state.  $I_{OUT}$  absolute maximum rating must be observed.

Note 4:  $V_{OUT} < GND$ ,  $V_{OUT} > V_{CC}$

**Operating Ranges (Note 1)**

Characteristics	Symbol	Rating	Unit
Power supply voltage	$V_{CC}$	1.8 to 3.6	V
		1.2 to 3.6 (Note 2)	
Input voltage	$V_{IN}$	-0.3 to 3.6	V
Output voltage	$V_{OUT}$	0 to 3.6 (Note 3)	V
		0 to $V_{CC}$ (Note 4)	
Output current	$I_{OH}/I_{OL}$	$\pm 24$ (Note 5)	mA
		$\pm 18$ (Note 6)	
		$\pm 6$ (Note 7)	
Operating temperature	$T_{opr}$	-40 to 85	°C
Input rise and fall time	$dt/dv$	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device.  
Unused inputs must be tied to either  $V_{CC}$  or GND.

Note 2: Data retention only

Note 3: OFF state

Note 4: High or low state

Note 5:  $V_{CC} = 3.0$  to 3.6 V

Note 6:  $V_{CC} = 2.3$  to 2.7 V

Note 7:  $V_{CC} = 1.8$  V

Note 8:  $V_{IN} = 0.8$  to 2.0 V,  $V_{CC} = 3.0$  V

## Electrical Characteristics

DC Characteristics ( $T_a = -40$  to  $85^\circ\text{C}$ ,  $2.7\text{ V} < V_{CC} \leq 3.6\text{ V}$ )

Characteristics		Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>	—		2.7 to 3.6	2.0	—	V
	L-level	V <sub>IL</sub>	—		2.7 to 3.6	—	0.8	
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = −100 μA	2.7 to 3.6	V <sub>CC</sub> − 0.2	—	V
				I <sub>OH</sub> = −12 mA	2.7	2.2	—	
				I <sub>OH</sub> = −18 mA	3.0	2.4	—	
				I <sub>OH</sub> = −24 mA	3.0	2.2	—	
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	2.7 to 3.6	—	0.2	
				I <sub>OL</sub> = 12 mA	2.7	—	0.4	
				I <sub>OL</sub> = 18 mA	3.0	—	0.4	
				I <sub>OL</sub> = 24 mA	3.0	—	0.55	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V	2.7 to 3.6	—	±5.0	μA	
3-state output OFF state current		I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = 0 to 3.6 V	2.7 to 3.6	—	±10.0	μA	
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V	0	—	10.0	μA	
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	2.7 to 3.6	—	20.0	μA	
			V <sub>CC</sub> ≤ (V <sub>IN</sub> , V <sub>OUT</sub> ) ≤ 3.6 V	2.7 to 3.6	—	±20.0		
Increase in I <sub>CC</sub> per input		ΔI <sub>CC</sub>	V <sub>IH</sub> = V <sub>CC</sub> − 0.6 V	2.7 to 3.6	—	750		

DC Characteristics ( $T_a = -40$  to  $85^\circ\text{C}$ ,  $2.3\text{ V} \leq V_{CC} \leq 2.7\text{ V}$ )

Characteristics		Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>			2.3 to 2.7	1.6	—	V
	L-level	V <sub>IL</sub>			2.3 to 2.7	—	0.7	
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = −100 μA	2.3 to 2.7	V <sub>CC</sub> − 0.2	—	V
				I <sub>OH</sub> = −6 mA	2.3	2.0	—	
				I <sub>OH</sub> = −12 mA	2.3	1.8	—	
				I <sub>OH</sub> = −18 mA	2.3	1.7	—	
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	2.3 to 2.7	—	0.2	
				I <sub>OL</sub> = 12 mA	2.3	—	0.4	
				I <sub>OL</sub> = 18 mA	2.3	—	0.6	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V	2.3 to 2.7	—	±5.0	μA	
3-state output OFF state current		I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = 0 to 3.6 V	2.3 to 2.7	—	±10.0	μA	
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V	0	—	10.0	μA	
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND	2.3 to 2.7	—	20.0	μA	
			V <sub>CC</sub> ≤ (V <sub>IN</sub> , V <sub>OUT</sub> ) ≤ 3.6 V	2.3 to 2.7	—	±20.0		

DC Characteristics ( $T_a = -40$  to  $85^\circ\text{C}$ ,  $1.8\text{ V} \leq V_{CC} < 2.3\text{ V}$ )

Characteristics		Symbol	Test Condition			Min	Max	Unit
					V <sub>CC</sub> (V)			
Input voltage	H-level	V <sub>IH</sub>	—		1.8 to 2.3	0.7 × V <sub>CC</sub>	—	V
	L-level	V <sub>IL</sub>	—		1.8 to 2.3	—	0.2 × V <sub>CC</sub>	
Output voltage	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = −100 μA	1.8	V <sub>CC</sub> − 0.2	—	V
				I <sub>OH</sub> = −6 mA	1.8	1.4	—	
	L-level	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	1.8	—	0.2	
				I <sub>OL</sub> = 6 mA	1.8	—	0.3	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		1.8	—	±5.0	μA
3-state output OFF state current		I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = 0 to 3.6 V		1.8	—	±10.0	μA
Power-off leakage current		I <sub>OFF</sub>	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	—	10.0	μA
Quiescent supply current		I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.8	—	20.0	μA
			V <sub>CC</sub> ≤ (V <sub>IN</sub> , V <sub>OUT</sub> ) ≤ 3.6 V		1.8	—	±20.0	

**AC Characteristics** ( $T_a = -40$  to  $85^\circ\text{C}$ , input:  $t_r = t_f = 2.0$  ns,  $C_L = 30$  pF,  $R_L = 500$   $\Omega$ ) (Note 1)

Characteristics	Symbol	Test Condition	$V_{CC}$ (V)	Min	Max	Unit
Propagation delay time (D-Q)	$t_{pLH}$ $t_{pHL}$	Figure 1, Figure 2	1.8	1.5	7.4	ns
			$2.5 \pm 0.2$	0.8	3.7	
			$3.3 \pm 0.3$	0.6	3.0	
Propagation delay time (LE-Q)	$t_{pLH}$ $t_{pHL}$	Figure 1, Figure 2	1.8	1.5	8.8	ns
			$2.5 \pm 0.2$	0.8	4.4	
			$3.3 \pm 0.3$	0.6	3.5	
Propagation delay time ( $\overline{PR}$ -Q)	$t_{pLH}$	Figure 1, Figure 3	1.8	1.5	9.8	ns
			$2.5 \pm 0.2$	0.8	5.6	
			$3.3 \pm 0.3$	0.6	4.0	
Propagation delay time ( $\overline{CLR}$ -Q)	$t_{pHL}$	Figure 1, Figure 3	1.8	1.5	9.2	ns
			$2.5 \pm 0.2$	0.8	4.6	
			$3.3 \pm 0.3$	0.6	3.7	
3-state output enable time	$t_{pZL}$ $t_{pZH}$	Figure 1, Figure 4	1.8	1.5	9.8	ns
			$2.5 \pm 0.2$	0.8	4.9	
			$3.3 \pm 0.3$	0.6	3.8	
3-state output disable time	$t_{pLZ}$ $t_{pHZ}$	Figure 1, Figure 4	1.8	1.5	7.6	ns
			$2.5 \pm 0.2$	0.8	4.2	
			$3.3 \pm 0.3$	0.6	3.7	
Minimum pulse width (LE, $\overline{PR}$ , $\overline{CLR}$ )	$t_W$ (H) $t_W$ (L)	Figure 1, Figure 2, Figure 3	1.8	4.0	—	ns
			$2.5 \pm 0.2$	1.5	—	
			$3.3 \pm 0.3$	1.5	—	
Minimum setup time	$t_s$	Figure 1, Figure 2	1.8	2.5	—	ns
			$2.5 \pm 0.2$	1.5	—	
			$3.3 \pm 0.3$	1.5	—	
Minimum hold time	$t_h$	Figure 1, Figure 2	1.8	1.0	—	ns
			$2.5 \pm 0.2$	1.0	—	
			$3.3 \pm 0.3$	1.0	—	
Minimum removal time	$t_{rem}$	Figure 1, Figure 5	1.8	4.0	—	ns
			$2.5 \pm 0.2$	3.0	—	
			$3.3 \pm 0.3$	2.0	—	
Output to output skew	$t_{oS LH}$ $t_{oS HL}$	(Note 2)	1.8	—	0.5	ns
			$2.5 \pm 0.2$	—	0.5	
			$3.3 \pm 0.3$	—	0.5	

Note 1: For  $C_L = 50$  pF, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.

( $t_{oS LH} = |t_{pLHm} - t_{pLHn}|$ ,  $t_{oS HL} = |t_{pHLm} - t_{pHLn}|$ )

**Dynamic Switching Characteristics**

( $T_a = 25^\circ\text{C}$ , input:  $t_r = t_f = 2.0\text{ ns}$ ,  $C_L = 30\text{ pF}$ ,  $R_L = 500\ \Omega$ )

Characteristics	Symbol	Test Condition	$V_{CC}\text{ (V)}$	Typ.	Unit
Quiet output maximum dynamic $V_{OL}$	$V_{OLP}$	$V_{IH} = 1.8\text{ V}$ , $V_{IL} = 0\text{ V}$ (Note)	1.8	0.25	V
		$V_{IH} = 2.5\text{ V}$ , $V_{IL} = 0\text{ V}$ (Note)	2.5	0.6	
		$V_{IH} = 3.3\text{ V}$ , $V_{IL} = 0\text{ V}$ (Note)	3.3	0.8	
Quiet output minimum dynamic $V_{OL}$	$V_{OLV}$	$V_{IH} = 1.8\text{ V}$ , $V_{IL} = 0\text{ V}$ (Note)	1.8	-0.25	V
		$V_{IH} = 2.5\text{ V}$ , $V_{IL} = 0\text{ V}$ (Note)	2.5	-0.6	
		$V_{IH} = 3.3\text{ V}$ , $V_{IL} = 0\text{ V}$ (Note)	3.3	-0.8	
Quiet output minimum dynamic $V_{OH}$	$V_{OHV}$	$V_{IH} = 1.8\text{ V}$ , $V_{IL} = 0\text{ V}$ (Note)	1.8	1.5	V
		$V_{IH} = 2.5\text{ V}$ , $V_{IL} = 0\text{ V}$ (Note)	2.5	1.9	
		$V_{IH} = 3.3\text{ V}$ , $V_{IL} = 0\text{ V}$ (Note)	3.3	2.2	

Note: Parameter guaranteed by design.

**Capacitive Characteristics ( $T_a = 25^\circ\text{C}$ )**

Characteristics	Symbol	Test Condition	$V_{CC}\text{ (V)}$	Typ.	Unit
Input capacitance	$C_{IN}$	—	1.8, 2.5, 3.3	6	pF
Output capacitance	$C_{OUT}$	—	1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	$C_{PD}$	$f_{IN} = 10\text{ MHz}$ (Note)	1.8, 2.5, 3.3	20	pF

Note:  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/18 \text{ (per bit)}$$



AC Test Circuit

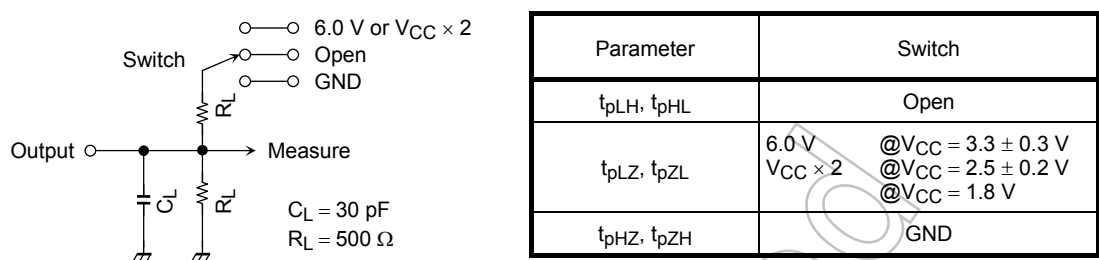


Figure 1

AC Waveform

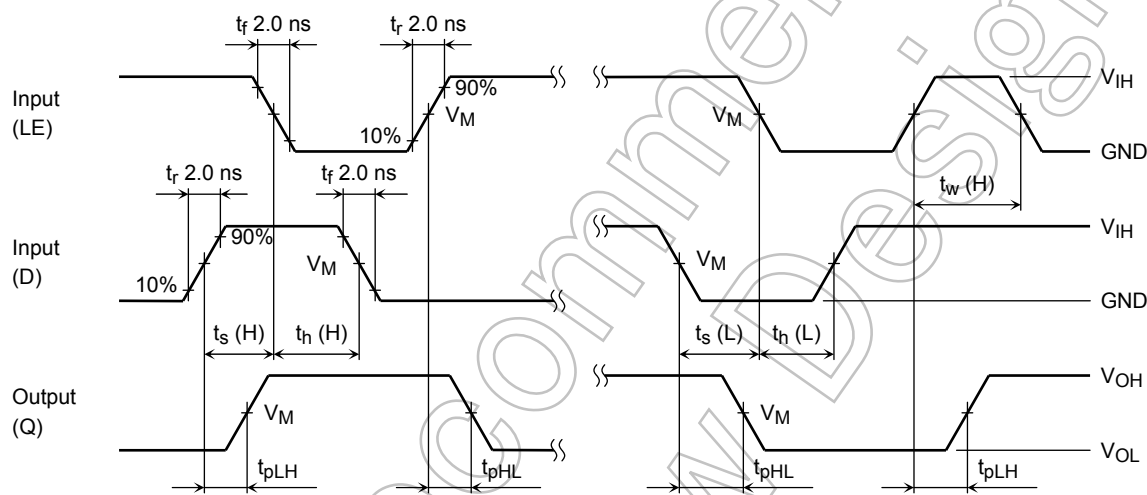


Figure 2  $t_{pLH}$ ,  $t_{pHL}$ ,  $t_w$ ,  $t_s$ ,  $t_h$

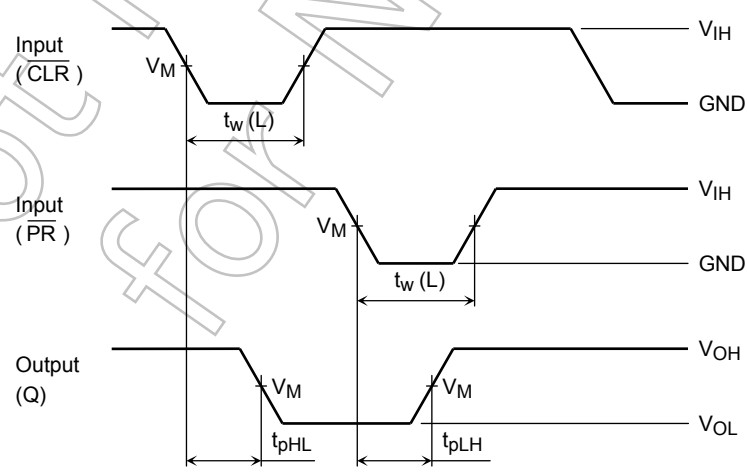


Figure 3  $t_{pLH}$ ,  $t_{pHL}$ ,  $t_w$

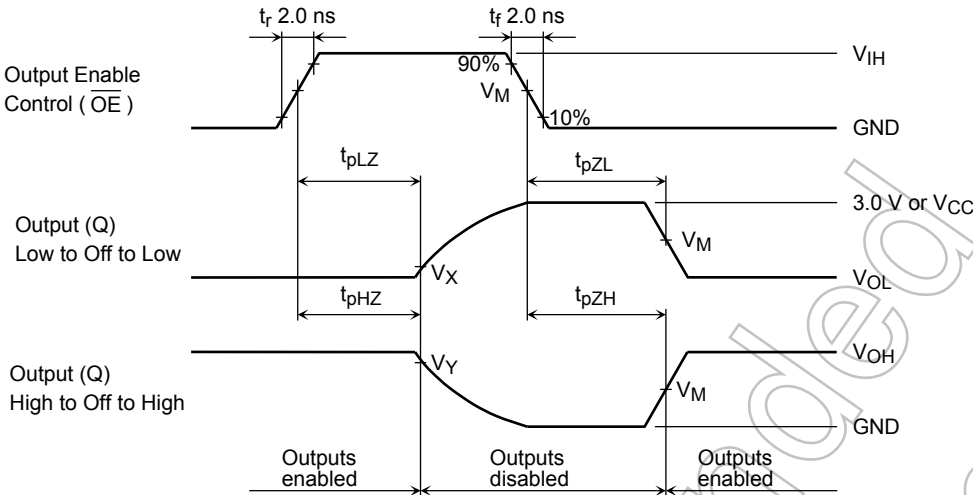


Figure 4  $t_{PLZ}$ ,  $t_{PHZ}$ ,  $t_{PZL}$ ,  $t_{PZH}$

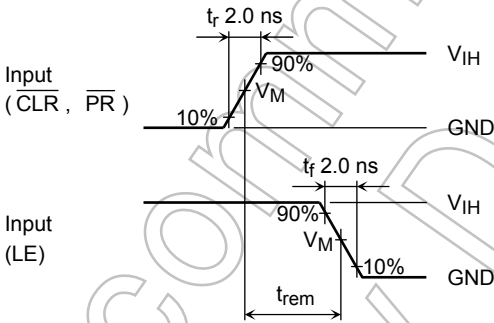


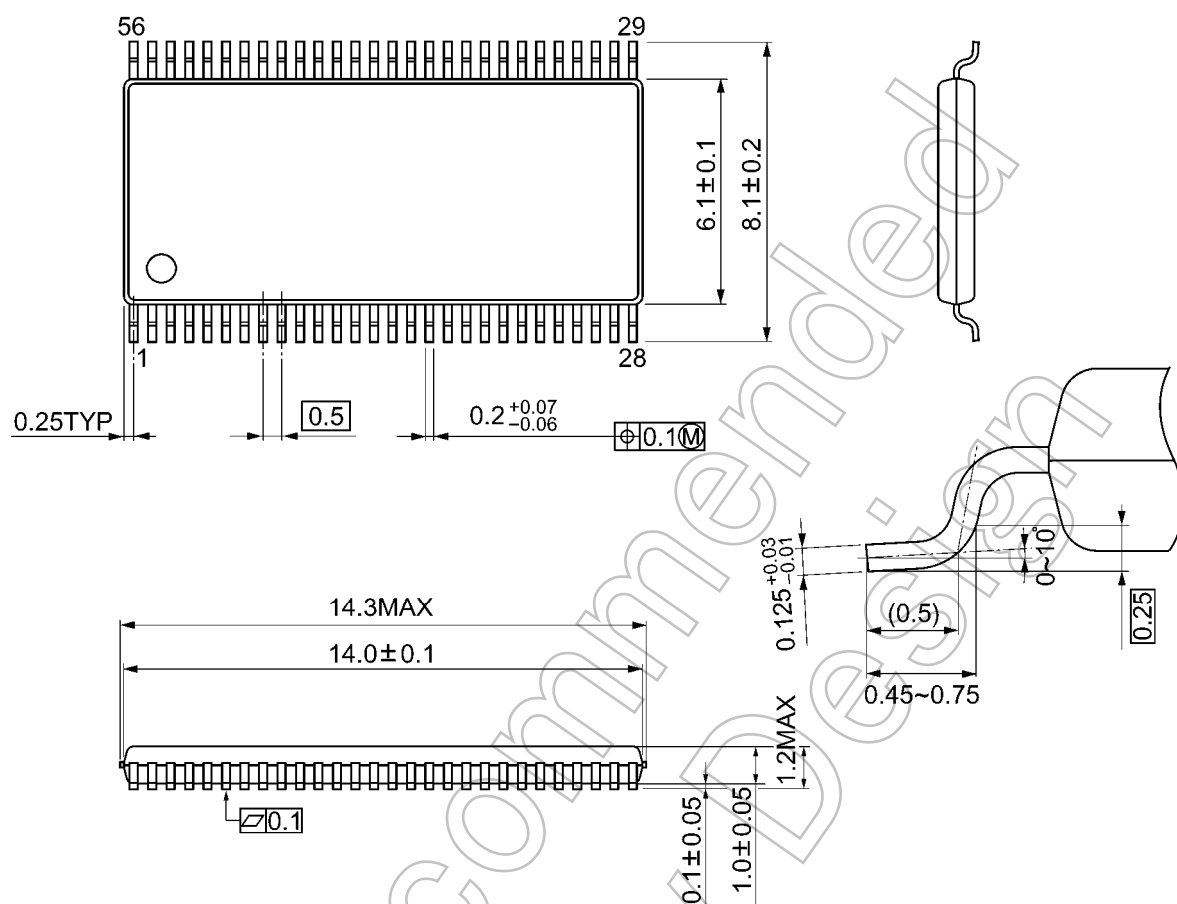
Figure 5  $t_{rem}$

Symbol	$V_{CC}$		
	$3.3 \pm 0.3 \text{ V}$	$2.5 \pm 0.2 \text{ V}$	$1.8 \text{ V}$
$V_{IH}$	$2.7 \text{ V}$	$V_{CC}$	$V_{CC}$
$V_M$	$1.5 \text{ V}$	$V_{CC}/2$	$V_{CC}/2$
$V_X$	$V_{OL} + 0.3 \text{ V}$	$V_{OL} + 0.15 \text{ V}$	$V_{OL} + 0.15 \text{ V}$
$V_Y$	$V_{OH} - 0.3 \text{ V}$	$V_{OH} - 0.15 \text{ V}$	$V_{OH} - 0.15 \text{ V}$

## Package Dimensions

TSSOP56-P-0061-0.50A

Unit: mm



Weight: 0.25 g (typ.)

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